

SCTH50N120-7

Silicon carbide Power MOSFET 1200 V, 65 A, 59 m Ω (typ., T_J = 150 °C) in an H²PAK-7 package

Datasheet - production data

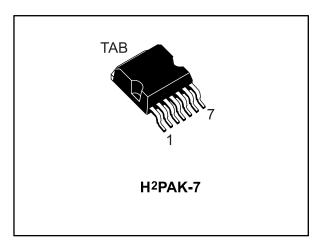
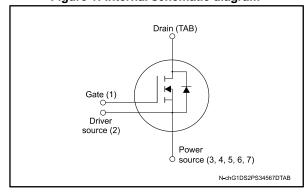


Figure 1: Internal schematic diagram



Features

- Very tight variation of on-resistance vs. temperature
- Very fast and robust intrinsic body diode
- Low capacitance
- Kelvin pin

Applications

- Solar inverters, UPS
- Motor drives
- High voltage DC-DC converters
- Switch mode power supplies

Description

This silicon carbide Power MOSFET is produced exploiting the advanced, innovative properties of wide bandgap materials. This results in unsurpassed on-resistance per unit area and very good switching performance almost independent of temperature. The outstanding thermal properties of the SiC material allow designers to use an industry-standard outline with significantly improved thermal capability. These features render the device perfectly suitable for high-efficiency and high power density applications.

Table 1: Device summary

Order code	Marking	Package	Packing	
SCTH50N120-7	SCT50N120	H ² PAK-7	Tape and reel	

Contents SCTH50N120-7

Contents

1	Electric	al ratings	3
2	Electric	cal characteristics	4
	2.2	Electrical characteristics (curves)	6
3	Packag	e information	9
	3.1	H ² PAK-7 package information	9
	3.2	H ² PAK packing information	12
4	Revisio	n history	14

SCTH50N120-7 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage	1200	V
V _{GS}	Gate-source voltage	-10 to 22	V
ID	Drain current (continuous) at T _C = 25 °C	65	Α
ID	Drain current (continuous) at T _C = 100 °C	50	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	130	Α
Ртот	Total dissipation at T _C = 25 °C	270	W
T _{stg}	Storage temperature range	FF to 17F	°C
Tj	Operating junction temperature range	-55 to 175	°C

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	0.55	°C/W
R _{thj-pcb} ⁽¹⁾	Thermal resistance junction-pcb	30	°C/W

Notes:

⁽¹⁾Pulse width limited by safe operating area.

 $^{^{(1)}}$ When mounted on 1 inch² FR-4, 2 Oz copper board.

Electrical characteristics SCTH50N120-7

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified).

Table 4: On/off-states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
	Zoro goto voltogo	V _{DS} = 1200 V, V _{GS} = 0 V			10	μΑ
IDSS	Zero-gate voltage drain current	V _{DS} = 1200 V, V _{GS} = 0 V, T _J = 175 °C		1		μΑ
I _{GSS}	Gate-body leakage current	V _{DS} = 0 V, V _{GS} = -10 to 22 V			±100	nA
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 1 \text{ mA}$	1.8	3.0	5.1	V
		$V_{GS} = 20 \text{ V}, I_{D} = 40 \text{ A}$		52	69	mΩ
R _{DS(on)}	R _{DS(on)} Static drain-source on-resistance	V _{GS} = 20 V, I _D = 40 A, T _J = 150 °C		59		mΩ
- 5(51)		V _{GS} = 20 V, I _D = 40 A, T _J = 175 °C		65		mΩ

Table 5: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance	\\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	ı	1900	ı	pF
Coss	Output capacitance	$V_{DS} = 400 \text{ V}, f = 1 \text{ MHz},$ $V_{GS} = 0 \text{ V}$	-	170	-	pF
Crss	Reverse transfer capacitance	VGS = 0 V	-	30	-	pF
Qg	Total gate charge	N/ 000 N/ 1 40 A	-	122	-	nC
Qgs	Gate-source charge	$V_{DD} = 800 \text{ V}, I_{D} = 40 \text{ A},$ $V_{GS} = 0 \text{ to } 20 \text{ V}$	-	19	-	nC
Q_{gd}	Gate-drain charge	VGS = 0 t0 20 V	ı	35	•	nC
Rg	Gate input resistance	f = 1 MHz open drain	-	1.9	-	Ω

Table 6: Switching energy (inductive load)

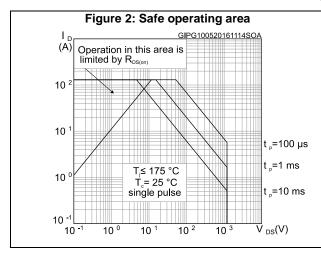
	3 - 3, (
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Eon	Turn-on switching energy	V _{DD} = 800 V, I _D = 40 A	ı	530	1	μJ
E _{off}	Turn-off switching energy	$R_G = 2.2 \Omega,$ $V_{GS} = -5 \text{ to } 20 \text{ V}$	ı	310	1	μJ
Eon	Turn-on switching energy	$V_{DD} = 800 \text{ V}, I_D = 40 \text{ A}$	-	670	-	μJ
E _{off}	Turn-off switching energy	R_G = 2.2 Ω , V_{GS} = -5 to 20 V T_J = 150 °C	-	334	-	μJ

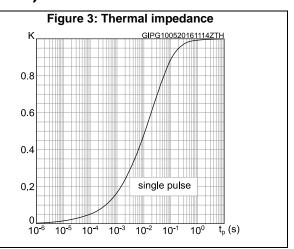
SCTH50N120-7 Electrical characteristics

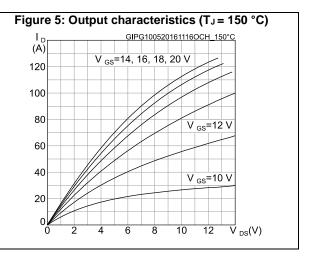
Table 7: Reverse SiC diode characteristics

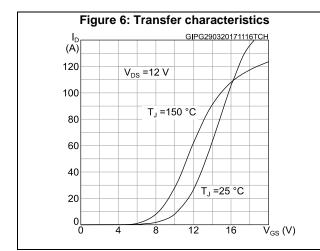
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{SD}	Diode forward voltage	I _F = 20 A, V _{GS} = 0 V	ı	3.5	ı	V
t _{rr}	Reverse recovery time	I _F = 40 A,	-	55		ns
Q_{rr}	Reverse recovery charge	di/dt = 2000/ns	-	230	-	nC
I _{RRM}	Reverse recovery current	$V_{DD} = 800 \text{ V}$	-	14	-	Α

2.2 Electrical characteristics (curves)









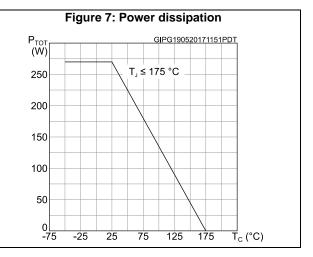


Figure 8: Gate charge vs gate-source voltage

V_{GS}
(V)

20

V_{DD} = 800 V
I_D = 40 A

8

20 40

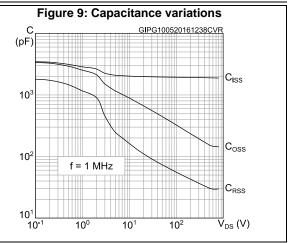
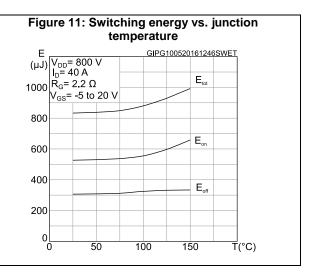


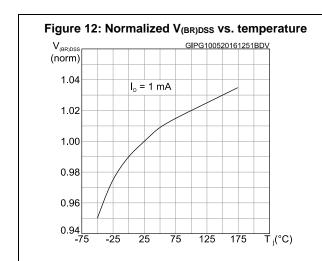
Figure 10: Switching energy vs. drain current GIPG100520161241SWEC (µJ) E to 2400 V_{DD}= 800 V R_G = 2.2 Ω 2000 V_{GS} = -5 to 20 V E on 1600 1200 E. 800 400 $\overline{\mathsf{I}}_{\mathsf{D}}(\mathsf{A})$ 20 40 60 80

60

80

100 120





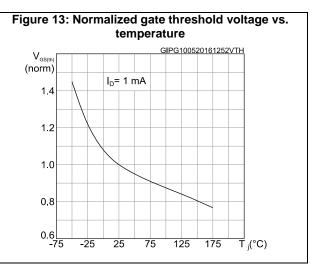
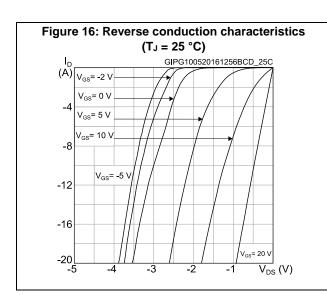
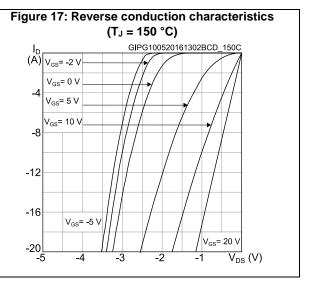


Figure 14: Normalized on-resistance vs. temperature

R_{DS((n))}
(norm)
2.0
V_{GS} = 20 V

1.5
1.0
0.5
0.0
-75 -25 25 75 125 175 T_i (°C)





3 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

3.1 H²PAK-7 package information

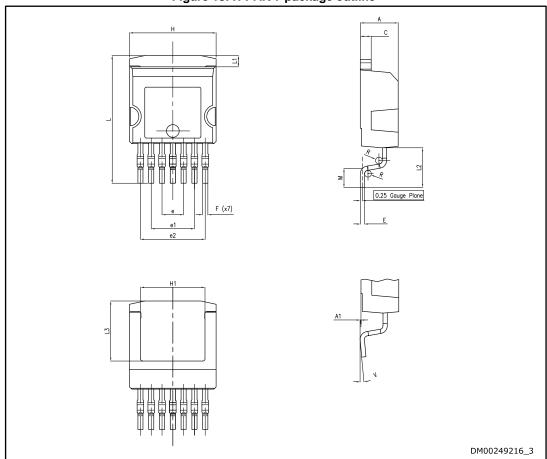


Figure 18: H²PAK-7 package outline

Table 8: H²PAK-7 package mechanical data

	m	ım
Dim.	Min.	Max.
A	4.30	4.80
A1	0.03	0.20
С	1.17	1.37
е	2.34	2.74
e1	4.88	5.28
e2	7.42	7.82
E	0.45	0.60
F	0.50	0.70
Н	10.00	10.40
H1	7.40	7.60
L	14.75	15.25
L1	1.27	1.40
L2	4.35	4.95
L3	6.85	7.25
M 1.90 2.50		2.50
R	0.20	0.60
V	0°	8°

12.20 0.80 0.80 2.54 5.08 7.62 footprint_DM00249216_3

Figure 19: H²PAK-7 recommended footprint



Dimensions are in mm.

3.2 H²PAK packing information

Figure 20: Tape outline

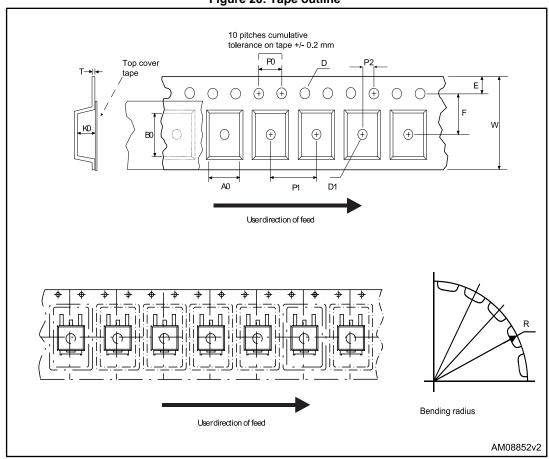


Figure 21: Reel outline

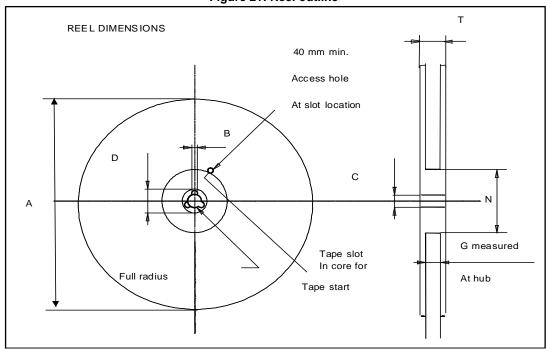


Table 9: Tape and reel mechanical data

Таре				Reel		
Dim	Dim.		Dim	mm		
DIM.	Min.	Max.	Dim.	Min.	Max.	
A0	10.5	10.7	А		330	
B0	15.7	15.9	В	1.5		
D	1.5	1.6	С	12.8	13.2	
D1	1.59	1.61	D	20.2		
Е	1.65	1.85	G	24.4	26.4	
F	11.4	11.6	N	100		
K0	4.8	5.0	Т		30.4	
P0	3.9	4.1				
P1	11.9	12.1	Base q	uantity	1000	
P2	1.9	2.1	Bulk qu	uantity	1000	
R	50					
Т	0.25	0.35				
W	23.7	24.3				

Revision history SCTH50N120-7

4 Revision history

Table 10: Document revision history

Date	Revision	Changes	
22-May-2017	1	First release	
23-May-2017	2	Datasheet promoted from preliminary to production data.	

IMPORTANT NOTICE - PLEASE READ CAREFULLY

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2017 STMicroelectronics - All rights reserved